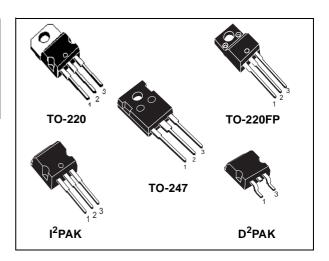


STP15NK50Z/FP, STB15NK50Z STB15NK50Z-1, STW15NK50Z

N-CHANNEL500V-0.30Ω-14ATO-220/FP/D²PAK/I²PAK/TO-247
Zener-Protected SuperMESH™Power MOSFET

TYPE	V _{DSS}	R _{DS(on)}	ΙD	Pw
STP15NK50Z	500 V	< 0.34 Ω	14 A	160 W
STP15NK50ZFP	500 V	< 0.34 Ω	14 A	40 W
STB15NK50Z	500 V	< 0.34 Ω	14 A	160 W
STB15NK50Z-1	500 V	< 0.34 Ω	14 A	160 W
STW15NK50Z	500 V	< 0.34 Ω	14 A	160 W

- TYPICAL $R_{DS}(on) = 0.30 \Omega$
- EXTREMELY HIGH dv/dt CAPABILITY
- 100% AVALANCHE TESTED
- GATE CHARGE MINIMIZED
- VERY LOW INTRINSIC CAPACITANCES
- VERY GOOD MANUFACTURING REPEATIBILITY

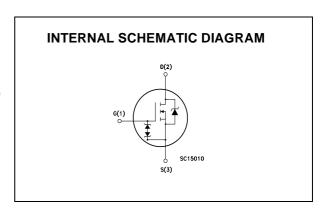


DESCRIPTION

The SuperMESH™ series is obtained through an extreme optimization of ST's well established strip-based PowerMESH™ layout. In addition to pushing on-resistance significantly down, special care is taken to ensure a very good dv/dt capability for the most demanding applications. Such series complements ST full range of high voltage MOSFETs including revolutionary MDmesh™ products.

APPLICATIONS

- HIGH CURRENT, HIGH SPEED SWITCHING
- IDEAL FOR OFF-LINE POWER SUPPLIES, ADAPTORS AND PFC
- LIGHTING



ORDERING INFORMATION

SALES TYPE	MARKING	PACKAGE	PACKAGING
STP15NK50Z	P15NK50Z	TO-220	TUBE
STP15NK50ZFP	P15NK50ZFP	TO-220FP	TUBE
STB15NK50ZT4	B15NK50Z	D ² PAK	TAPE & REEL
STB15NK50Z	B15NK60Z	D ² PAK	TUBE (ONLY UNDER REQUEST)
STB15NK50Z-1	B15NK50Z	I ² PAK	TUBE
STW15NK50Z	W15NK50Z	TO-247	TUBE

August 2002 1/14

ABSOLUTE MAXIMUM RATINGS

Symbol	Parameter		Value		Unit
		STP15NK50Z STB15NK50Z STB15NK50Z-1	STP15NK50ZFP	STW15NK50Z	
V _{DS}	Drain-source Voltage (V _{GS} = 0)		500		V
V_{DGR}	Drain-gate Voltage ($R_{GS} = 20 \text{ k}\Omega$)		500		V
V _{GS}	Gate- source Voltage		± 30		V
I _D	Drain Current (continuous) at T _C = 25°C	14 14 (*) 14			Α
I _D	Drain Current (continuous) at T _C = 100°C	8.8	8.8 (*)	8.8	Α
I _{DM} (•)	Drain Current (pulsed)	56	56 (*)	56	Α
P _{TOT}	Total Dissipation at T _C = 25°C	160	40	160	W
	Derating Factor	1.28	0.32	1.28	W/°C
I _{GS}	Gate-source Current (DC)		± 20		mA
V _{ESD(G-S)}	Gate source ESD(HBM-C=100pF, R=1.5KΩ)		4000		V
dv/dt (1)	Peak Diode Recovery voltage slope	4.5		V/ns	
V _{ISO}	Insulation Withstand Voltage (DC)	-	2500	-	V
T _j T _{stg}	Operating Junction Temperature Storage Temperature	-55 to 150 -55 to 150			°C

THERMAL DATA

		TO-220 D ² PAK TO-		TO-220FP	TO-247	
Rthj-case	Thermal Resistance Junction-case Max	0.	0.78		0.78	°C/W
Rthj-pcb	Thermal Resistance Junction-pcb Max (#)		60			°C/W
Rthj-amb	Thermal Resistance Junction-ambient Max	62.5			50	°C/W
Tı	Maximum Lead Temperature For Soldering Purpose	300			°C	

AVALANCHE CHARACTERISTICS

Symbol	Parameter	Max Value	Unit
I _{AR}	Avalanche Current, Repetitive or Not-Repetitive (pulse width limited by T_j max)	14	А
E _{AS}	Single Pulse Avalanche Energy (starting $T_j = 25$ °C, $I_D = I_{AR}$, $V_{DD} = 50$ V)	300	mJ

GATE-SOURCE ZENER DIODE

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
BV _{GSO}	Gate-Source Breakdown Voltage	Igs=± 1mA (Open Drain)	30			٧

^(#) When mounted on minimum Footprint

PROTECTION FEATURES OF GATE-TO-SOURCE ZENER DIODES

The built-in back-to-back Zener diodes have specifically been designed to enhance not only the device's ESD capability, but also to make them safely absorb possible voltage transients that may occasionally be applied from gate to source. In this respect the Zener voltage is appropriate to achieve an efficient and cost-effective intervention to protect the device's integrity. These integrated Zener diodes thus avoid the usage of external components.

_____ 2/14

^(•) Pulse width limited by safe operating area (1) I_{SD} ≤14A, di/dt ≤200A/µs, V_{DD} ≤ V_{(BR)DSS}, T_j ≤ T_{JMAX}. (*) Limited only by maximum temperature allowed

ELECTRICAL CHARACTERISTICS (TCASE =25°C UNLESS OTHERWISE SPECIFIED) ON/OFF

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
V _{(BR)DSS}	Drain-source Breakdown Voltage	$I_D = 1 \text{ mA}, V_{GS} = 0$	500			V
I _{DSS}	Zero Gate Voltage Drain Current (V _{GS} = 0)	V_{DS} = Max Rating V_{DS} = Max Rating, T_{C} = 125 °C			1 50	μΑ μΑ
I _{GSS}	Gate-body Leakage Current (V _{DS} = 0)	V _{GS} = ± 20V			±10	μΑ
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}$, $I_D = 100\mu A$	3	3.75	4.5	V
R _{DS(on)}	Static Drain-source On Resistance	V _{GS} = 10V, I _D = 7 A		0.30	0.34	Ω

DYNAMIC

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
g _{fs} (1)	Forward Transconductance	V _{DS} = 15 V _, I _D = 7 A		12		S
C _{iss} C _{oss} C _{rss}	Input Capacitance Output Capacitance Reverse Transfer Capacitance	V _{DS} = 25V, f = 1 MHz, V _{GS} = 0		2260 264 64		pF pF pF
Coss eq. (3)	Equivalent Output Capacitance	$V_{GS} = 0V$, $V_{DS} = 0V$ to 400V		150		pF

SWITCHING ON

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
t _{d(on)} t _r	Turn-on Delay Time Rise Time	$V_{DD} = 250 \text{ V}, I_D = 7 \text{ A}$ $R_G = 4.7\Omega \text{ V}_{GS} = 10 \text{ V}$ (Resistive Load see, Figure 3)		20 23		ns ns
Q _g Q _{gs} Q _{gd}	Total Gate Charge Gate-Source Charge Gate-Drain Charge	V _{DD} = 400V, I _D = 14 A, V _{GS} = 10V		76 15 40	106	nC nC nC

SWITCHING OFF

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
t _{d(off)}	Turn-off Delay Time Fall Time	V_{DD} = 250 V, I_D = 7 A R_G = 4.7 Ω V _{GS} = 10 V (Resistive Load see, Figure 3)		62 15		ns ns
$\begin{array}{c} t_{r(\text{Voff})} \\ t_{f} \\ t_{c} \end{array}$	Off-voltage Rise Time Fall Time Cross-over Time	$V_{DD} = 400 \text{V}, I_D = 14 \text{ A},$ $R_G = 4.7\Omega, V_{GS} = 10 \text{V}$ (Inductive Load see, Figure 5)		13 11 28		ns ns ns

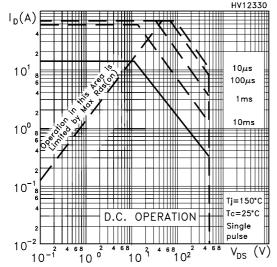
SOURCE DRAIN DIODE

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
I _{SD} I _{SDM} (2)	Source-drain Current Source-drain Current (pulsed)				14 56	A A
V _{SD} (1)	Forward On Voltage	I _{SD} = 14 A, V _{GS} = 0			1.6	V
t _{rr} Q _{rr} I _{RRM}	Reverse Recovery Time Reverse Recovery Charge Reverse Recovery Current	I_{SD} = 14 A, di/dt = 100A/ μ s V_{DD} = 29V, T_j = 150°C (see test circuit, Figure 5)		428 4.2 20		ns μC A

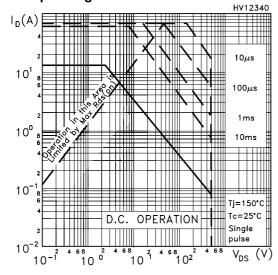
Note: 1. Pulsed: Pulse duration = $300 \mu s$, duty cycle 1.5 %.

^{1.} I dised. I dise duration = 300 µs, duty cycle 1.5 %.
2. Pulse width limited by safe operating area.
3. C_{oss eq.} is defined as a constant equivalent capacitance giving the same charging time as C_{oss} when V_{DS} increases from 0 to 80% V_{DSS}.

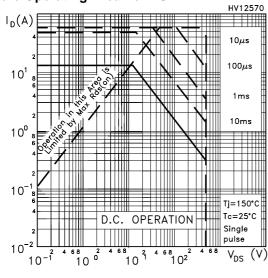
Safe Operating Area For TO-220/D2PAK/I2PAK



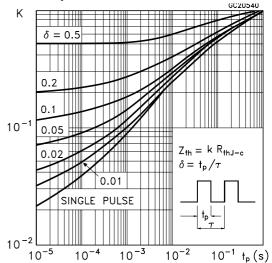
Safe Operating Area For TO-220FP



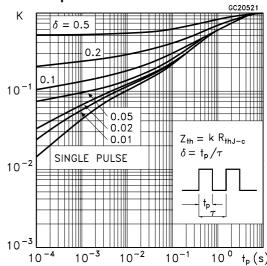
Safe Operating Area For TO-247



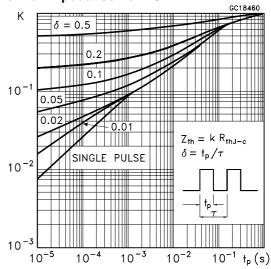
Thermal Impedance For TO-220/D2PAK/I2PAK



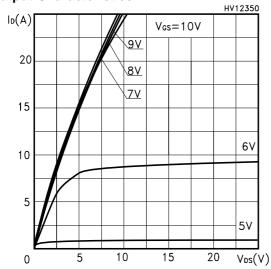
Thermal Impedance For TO-220FP



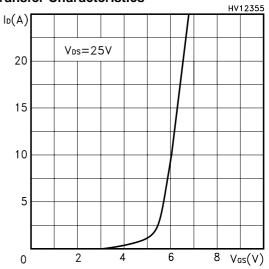
Thermal Impedance For TO-247



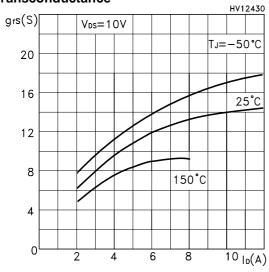
Output Characteristics



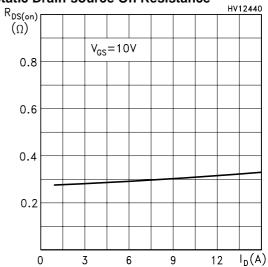
Transfer Characteristics



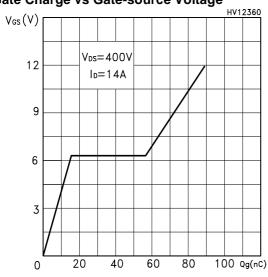
Transconductance



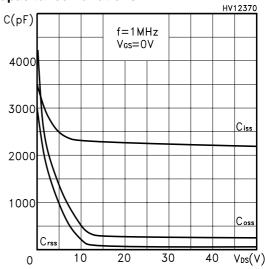
Static Drain-source On Resistance



Gate Charge vs Gate-source Voltage

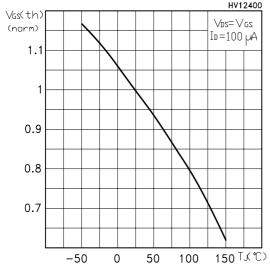


Capacitance Variations

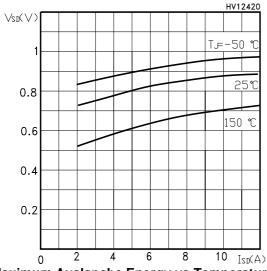


47/°

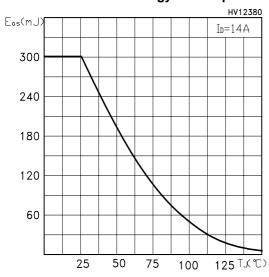
Normalized Gate Threshold Voltage vs Temp. HV12400



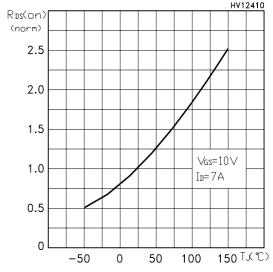
Source-drain Diode Forward Characteristics



Maximum Avalanche Energy vs Temperature



Normalized On Resistance vs Temperature



Normalized BVDSS vs Temperature

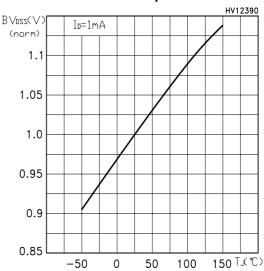


Fig. 1: Unclamped Inductive Load Test Circuit

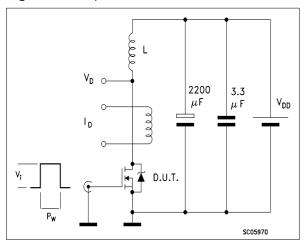


Fig. 3: Switching Times Test Circuit For

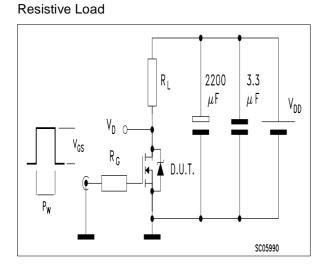


Fig. 5: Test Circuit For Inductive Load Switching And Diode Recovery Times

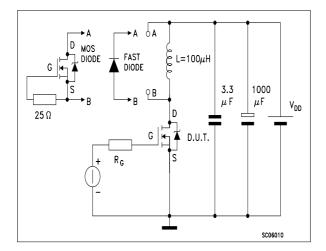


Fig. 2: Unclamped Inductive Waveform

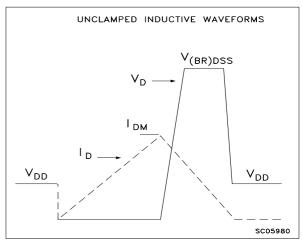
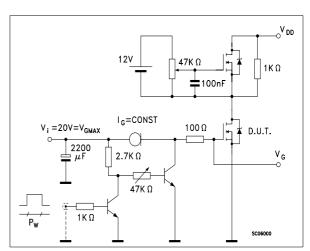
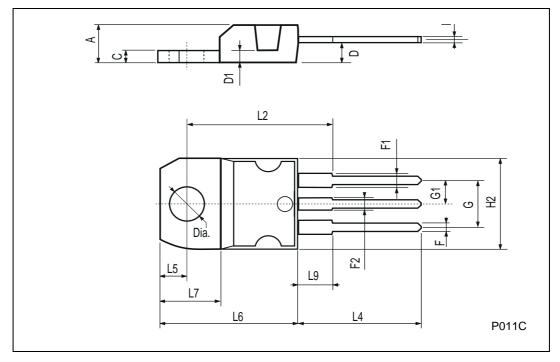


Fig. 4: Gate Charge test Circuit



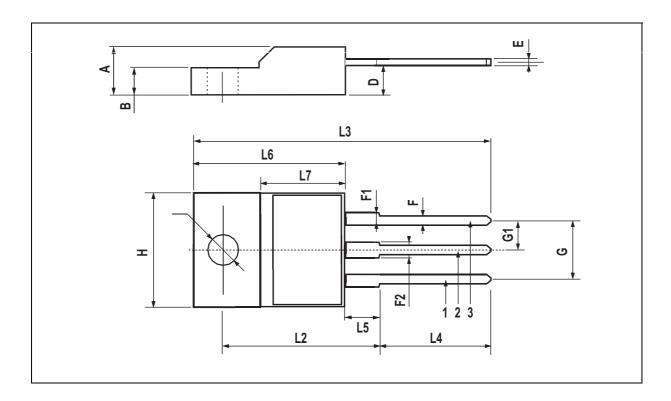
TO-220 MECHANICAL DATA

DIM		mm			inch	
DIM.	MIN.	TYP.	MAX.	MIN.	TYP.	MAX.
А	4.40		4.60	0.173		0.181
С	1.23		1.32	0.048		0.051
D	2.40		2.72	0.094		0.107
D1		1.27			0.050	
Е	0.49		0.70	0.019		0.027
F	0.61		0.88	0.024		0.034
F1	1.14		1.70	0.044		0.067
F2	1.14		1.70	0.044		0.067
G	4.95		5.15	0.194		0.203
G1	2.4		2.7	0.094		0.106
H2	10.0		10.40	0.393		0.409
L2		16.4			0.645	
L4	13.0		14.0	0.511		0.551
L5	2.65		2.95	0.104		0.116
L6	15.25		15.75	0.600		0.620
L7	6.2		6.6	0.244		0.260
L9	3.5		3.93	0.137		0.154
DIA.	3.75		3.85	0.147		0.151



TO-220FP MECHANICAL DATA

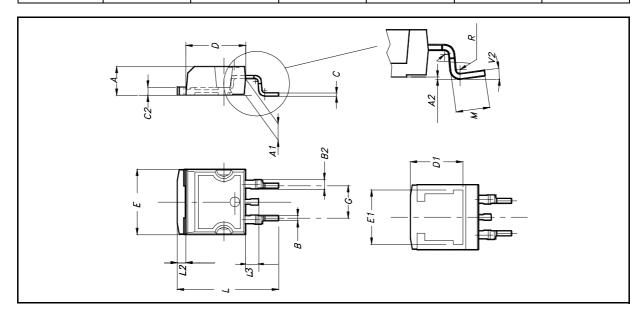
DIM.	mm.			inch		
	MIN.	TYP	MAX.	MIN.	TYP.	MAX.
Α	4.4		4.6	0.173		0.181
В	2.5		2.7	0.098		0.106
D	2.5		2.75	0.098		0.108
Е	0.45		0.7	0.017		0.027
F	0.75		1	0.030		0.039
F1	1.15		1.5	0.045		0.067
F2	1.15		1.5	0.045		0.067
G	4.95		5.2	0.195		0.204
G1	2.4		2.7	0.094		0.106
Н	10		10.4	0.393		0.409
L2		16			0.630	
L3	28.6		30.6	1.126		1.204
L4	9.8		10.6	.0385		0.417
L5	2.9		3.6	0.114		0.141
L6	15.9		16.4	0.626		0.645
L7	9		9.3	0.354		0.366
Ø	3		3.2	0.118		0.126



47/.

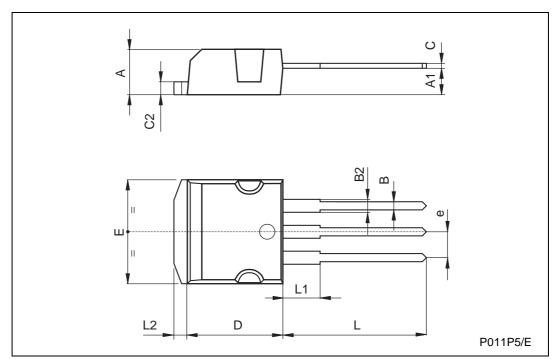
D²PAK MECHANICAL DATA

DIM.	mm.			inch			
	MIN.	TYP	MAX.	MIN.	TYP.	MAX.	
А	4.4		4.6	0.173		0.181	
A1	2.49		2.69	0.098		0.106	
A2	0.03		0.23	0.001		0.009	
В	0.7		0.93	0.027		0.036	
B2	1.14		1.7	0.044		0.067	
С	0.45		0.6	0.017		0.023	
C2	1.23		1.36	0.048		0.053	
D	8.95		9.35	0.352		0.368	
D1		8			0.315		
E	10		10.4	0.393			
E1		8.5			0.334		
G	4.88		5.28	0.192		0.208	
L	15		15.85	0.590		0.625	
L2	1.27		1.4	0.050		0.055	
L3	1.4		1.75	0.055		0.068	
М	2.4		3.2	0.094		0.126	
R		0.4			0.015		
V2	00		80				



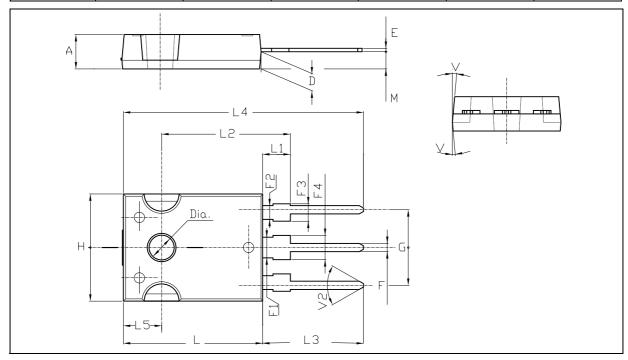
TO-262 (I²PAK) MECHANICAL DATA

DIM.	mm			inch		
	MIN.	TYP.	MAX.	MIN.	TYP.	MAX.
А	4.4		4.6	0.173		0.181
A1	2.49		2.69	0.098		0.106
В	0.7		0.93	0.027		0.036
B2	1.14		1.7	0.044		0.067
С	0.45		0.6	0.017		0.023
C2	1.23		1.36	0.048		0.053
D	8.95		9.35	0.352		0.368
е	2.4		2.7	0.094		0.106
E	10		10.4	0.393		0.409
L	13.1		13.6	0.515		0.531
L1	3.48		3.78	0.137		0.149
L2	1.27		1.4	0.050		0.055



TO-247 MECHANICAL DATA

DIM.		mm.			inch	
	MIN.	TYP	MAX.	MIN.	TYP.	MAX.
Α	4.85		5.15	0.19		0.20
D	2.20		2.60	0.08		0.10
Е	0.40		0.80	0.015		0.03
F	1		1.40	0.04		0.05
F1		3			0.11	
F2		2			0.07	
F3	2		2.40	0.07		0.09
F4	3		3.40	0.11		0.13
G		10.90			0.43	
Н	15.45		15.75	0.60		0.62
L	19.85		20.15	0.78		0.79
L1	3.70		4.30	0.14		0.17
L2		18.50			0.72	
L3	14.20		14.80	0.56		0.58
L4		34.60			1.36	
L5		5.50			0.21	
М	2		3	0.07		0.11
V		5°			5°	
V2		60°			60°	
Dia	3.55		3.65	0.14		0.143

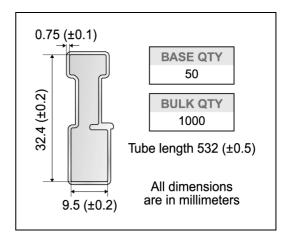


D²PAK FOOTPRINT

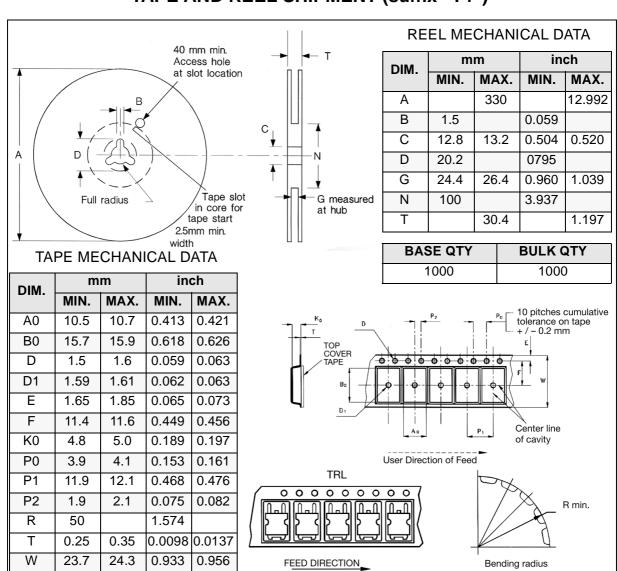
16.90 12.20 5.08 ________1.60 → →3.50 ← 9.75 -All dimensions are in millimeters

on sales type

TUBE SHIPMENT (no suffix)*



TAPE AND REEL SHIPMENT (suffix "T4")*



Information furnished is believed to be accurate and reliable. However, STMicroelectronics assumes no responsibility for the consequences of use of such information nor for any infringement of patents or other rights of third parties which may result from its use. No license is granted by implication or otherwise under any patent or patent rights of STMicroelectronics. Specifications mentioned in this publication are subject to change without notice. This publication supersedes and replaces all information previously supplied. STMicroelectronics products are not authorized for use as critical components in life support devices or systems without express written approval of STMicroelectronics.

© The ST logo is a registered trademark of STMicroelectronics

© 2002 STMicroelectronics - Printed in Italy - All Rights Reserved
STMicroelectronics GROUP OF COMPANIES

Australia - Brazil - Canada - China - Finland - France - Germany - Hong Kong - India - Israel - Italy - Japan - Malaysia - Malta - Morocco
Singapore - Spain - Sweden - Switzerland - United Kingdom - United States. © http://www.st.com

477.